

Is Now Part of



ON Semiconductor®

To learn more about ON Semiconductor, please visit our website at <u>www.onsemi.com</u>

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor dates sheds, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor dates sheds and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use on similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor and its officers, employees, subsidiaries, affliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out or i, directly or indirectly, any lay bed ON Semiconductor and its officers, employees, ween if such claim alleges that ON Semiconductor was negligent regarding the d

January 2016



FAN73893 3-Phase Half-Bridge Gate-Drive IC

Features

- Floating Channel for Bootstrap Operation to +600 V
- Typically 350 mA/650 mA Sourcing/Sinking Current-Driving Capability for All Channels
- Extended Allowable Negative V_S Swing to -9.8 V for Signal Propagation at V_{DD}=V_{BS}=15 V
- Outputs Out of Phase with Input Signals
- Over-Current Shutdown Turns Off All Six Drivers
- Matched Propagation Delay for All Channels
- 3.3 V and 5.0 V Input Logic Compatible
- Adjustable Fault-Clear Timing
- Signal Interlocking of Every Phase to Prevent Cross-Conduction
- Common-Mode dVs/dt Noise-Canceling Circuit
- Built-in Advanced Input Filter
- Built-in Soft Turn-Off Function
- Built-in UVLO Functions for All Channels

Applications

- 3-Phase Motor Inverter Driver
- Air Conditioner, Washing Machine, Refrigerator, Dish Washer
- Industrial Inverter Sewing Machine, Power Tool
- General-Purpose Three-Phase Inverter

Description

The FAN73893 is a monolithic three-phase half-bridge gate-drive IC designed for high-voltage, high-speed, driving MOSFETs and IGBTs operating up to +600 V.

Fairchild's high-voltage process and common-mode noise-canceling technique provide stable operation of high-side drivers under high-dV_s/dt noise circumstances.

An advanced level-shift circuit allows high-side gate driver operation up to V_S = -9.8 V (typical) for V_{BS} =15 V.

The protection functions include under-voltage lockout, inter-lock function and inverter over-current trip with an automatic fault-clear function. Over-current protection that terminates all six outputs can be derived from an external current-sense resistor. An open-drain fault signal is provided to indicate that an over-current or under-voltage shutdown has occurred. The UVLO circuits prevent malfunction when V_{DD} and V_{BS} are lower than the threshold voltage.

Output drivers typically source and sink 350 mA and 650 mA, respectively; which is suitable for three-phase half-bridge applications in motor drive systems.



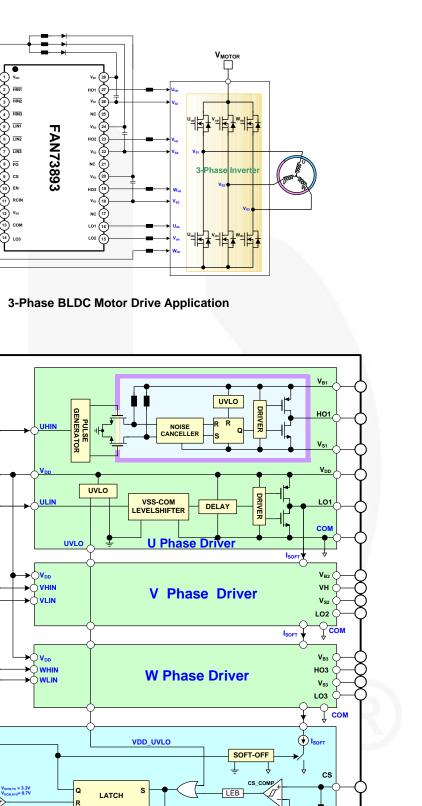


Ordering Information

Part Number	Package	Operating Temperature	Packing Method
FAN73893MX ⁽¹⁾	28-Lead, Small Outline Integrated Circuit, (SOIC)	-40 to +125°C	Tape & Reel

Note:

1. These devices passed wave-soldering test by JESD22A-111.





HIN

5 cs

CRCB

EN

Vss cor



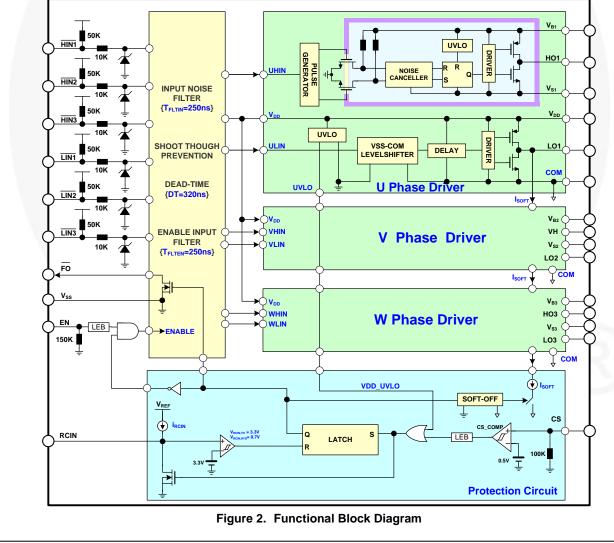
Typical Application Diagram

3-Phase BLDC Motor

CONTROL

Controlle

VDD 🗋



© 2015 Fairchild Semiconductor Corporation FAN73893 • Rev.1.1

FAN73893 — 3-Phase Half-Bridge Gate-Drive IC

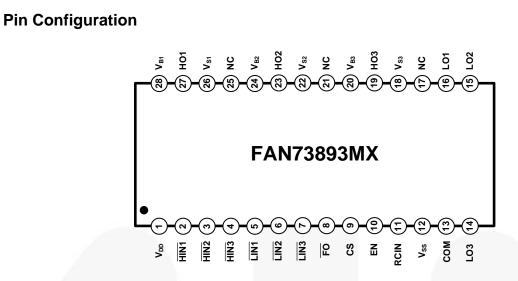


Figure 3. Pin Assignments

Pin Definitions

Pin	Name	Description
1	V _{DD}	Logic and low-side gate driver power supply voltage
2	HIN1	Logic Input 1 for high-side gate 1 driver
3	HIN2	Logic Input 2 for high-side gate 2 driver
4	HIN3	Logic Input 3 for high-side gate 3 driver
5	LIN1	Logic Input 1 for low-side gate 1 driver
6	LIN2	Logic Input 2 for low-side gate 2 driver
7	LIN3	Logic Input 3 for low-side gate 3 driver
8	FO	Fault output with open drain (indicates over-current and low-side under-voltage)
9	CS	Analog input for over-current shutdown
10	EN	Logic input for shutdown functionality
11	RCIN	An external RC network input used to define the fault-clear delay
12	V _{SS}	Logic ground
13	COM	Low-side driver return
14	LO3	Low-side gate driver 3 output
15	LO2	Low-side gate driver 2 output
16	LO1	Low-side gate driver 1 output
17, 21, 25	NC	No connect
18	V _{S3}	High-side driver 3 floating supply offset voltage
19	HO3	High-side driver 3 gate driver output
20	V _{B3}	High-side driver 3 floating supply
22	V _{S2}	High-side driver 2 floating supply offset voltage
23	HO2	High-side driver 2 gate driver output
24	V_{B2}	High-side driver 2 floating supply
26	V _{S1}	High-side driver 1 floating supply offset voltage
27	HO1	High-side driver 1 gate driver output
28	V _{B1}	High-side driver 1 floating supply

Absolute Maximum Ratings

Stresses exceeding the Absolute Maximum Ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only. $T_A=25^{\circ}C$, unless otherwise specified.

Symbol	Parameter	Min.	Max.	Unit
Vs	High-Side Floating Offset Voltage	V _{B1,2,3} -25	V _{B1,2,3} +0.3	V
VB	High-Side Floating Supply Voltage	-0.3	625.0	V
V _{DD}	Low-Side and Logic-Fixed supply voltage	-0.3	25.0	V
V _{HO}	High-Side Floating Output Voltage V _{HO1,2,3}	V _{S1,2,3} -0.3	V _{B1,2,3} +0.3	V
V _{LO}	Low-Side Floating Output Voltage VLO1,2,3	-0.3	V _{DD} +0.3	V
V _{IN}	Input Voltage (HINx, LINx, CS, and EN) ⁽²⁾	V _{SS} - 0.3	V _{SS} + 5.5	V
V _{FO}	Fault Output Voltage (FO)	-0.3	V _{DD} +0.3	V
dVs/dt	Allowable Offset Voltage Slew Rate		±50	V/ns
PD	Power Dissipation ^(3,4)		1.4	W
θ _{JA}	Thermal Resistance		70	°C/W
TJ	Junction Temperature		150	°C
T _{STG}	Storage Temperature	-55	150	°C

Notes:

2. All input voltage (HINx , LINx , CS, and EN) are referenced to V_{SS} and do not exceed maximum voltage rating.

 Mounted on 76.2 x 114.3 x 1.6mm PCB (FR-4 glass epoxy material). Refer to the following standards: JESD51-2: Integral circuit's thermal test method environmental conditions, natural convection; JESD51-3: Low effective thermal conductivity test board for leaded surface-mount packages.

4. Do not exceed maximum power dissipation (P_D) under any circumstances.

Recommended Operating Conditions

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to Absolute Maximum Ratings.

Symbol	Parameter	Min.	Max.	Unit
V _{B1,2,3}	High-Side Floating Supply Voltage	V _{S1,2,3} +10	V _{S1,2,3} +20	V
V _{S1,2,3}	High-Side Floating Supply Offset Voltage	6-V _{DD}	600	V
V _{DD}	Low-Side and Logic Fixed Supply Voltage	10	20	V
V _{HO1,2,3}	High-Side Output Voltage	V _{S1,2,3}	V _{B1,2,3}	V
V _{LO1,2,3}	Low-Side Output Voltage	COM	V _{DD}	V
V _{FO}	Fault Output Voltage (FO)	V _{SS}	V _{DD}	V
V _{CS}	Current-Sense Pin Input Voltage	V _{SS}	V _{SS} + 5	V
V _{IN}	Logic Input Voltage (HIN1,2,3 and LIN1,2,3)	V _{SS}	V _{SS} + 5	V
V _{SS}	Logic Ground	-5	5	V
TA	Ambient Temperature	-40	+125	°C

Electrical Characteristics

 V_{BIAS} (V_{DD} , $V_{BS1,2,3}$) = 15.0 V and T_A = 25°C unless otherwise specified. The V_{IN} and I_{IN} parameters are referenced to V_{SS} and are applicable to all six channels. The V_0 and I_0 parameters are referenced to $V_{S1,2,3}$ and COM and are applicable to the respective output leads: HO1,2,3 and LO1,2,3. The V_{DDUV} parameters are referenced to V_{SS} . The V_{BSUV} parameters are referenced to $V_{S1,2,3}$.

Symbol	Parameter	Condition	Min.	Тур.	Max.	Unit
Low-Side	Power Supply Section			•		
	Quiescent V _{DD} Supply Current	V _{LIN1,2,3} =5 V or open, EN=0 V		250	400	μA
I _{PDD}	Operating V _{DD} Supply Current	f _{LIN1,2,3} =20 kHz, rms Value		550	750	μA
V _{DDUV+}	V _{DD} Supply Under-Voltage Positive-Going Threshold	V _{DD} =Sweep	7.5	8.5	9.3	V
V _{DDUV-}	V _{DD} Supply Under-Voltage Negative-Going Threshold	V _{DD} =Sweep	7.0	8.0	8.7	V
V _{DDHYS}	V _{DD} Supply Under-Voltage Lockout Hysteresis	V _{DD} =Sweep		0.5		V
Bootstrap	pped Power Supply Section					
V _{BSUV+}	V _{BS} Supply Under-Voltage Positive-Going Threshold	V _{BS1,2,3} =Sweep	7.5	8.5	9.3	V
V _{BSUV-}	V _{BS} Supply Under-Voltage Negative-Going Threshold	V _{BS1,2,3} =Sweep	7.0	8.0	8.7	V
V _{BSHYS}	V _{BS} Supply Under-Voltage Lockout Hysteresis	V _{BS1,2,3} =Sweep		0.5		V
I _{LK}	Offset Supply Leakage Current	V _{B1,2,3} =V _{S1,2,3} =600 V			10	μA
I _{QBS}	Quiescent V _{BS} Supply Current	V _{HIN1,2,3} =0 V or 5 V, EN=0 V	10	50	80	μA
I _{PBS}	Operating V _{BS} Supply Current	f _{HIN1,2,3} =20 kHz, rms Value	200	320	480	μA
Gate Driv	ver Output Section			•		
V _{OH}	High-Level Output voltage, V _{BIAS} -V _O	I _O =0 mA (No Load)			100	mV
V _{OL}	Low-Level Output voltage, Vo	Io=0 mA (No Load)			100	mV
I _{O+}	Output HIGH Short-Circuit Pulse Current ⁽⁵⁾	V _O =0 V, V _{IN} =0 V with PW≤10 µs	250	350		mA
I _{O-}	Output LOW Short-Circuit Pulsed Current ⁽⁵⁾	V _O =15 V, V _{IN} =5 V with PW≤10 µs	500	650		mA
Vs	Allowable Negative V_S Pin Voltage for HIN Signal Propagation to HO			-9.8	-9.0	V
Logic Inp	out Section					
V _{IH}	Logic "0" Input Voltage HIN1,2,3, LIN1,2,3		2.5			V
VIL	Logic "1" Input Voltage HIN1,2,3, LIN1,2,3			1	0.8	V
I _{IN+}	Logic Input Bias Current (HO=LO=HIGH)	V _{IN} =0 V	77	100	143	μA
I _{IN-}	Logic Input Bias Current (HO=LO=LOW)	V _{IN} =5 V		8.5	25	μA
R _{IN}	Logic Input Pull-Up Resistance		35	50	65	KΩ
Enable C	ontrol Section (EN)		•			
$V_{\text{EN+}}$	Enable Positive-Going Threshold Voltage		2.5			V
V_{EN-}	Enable Negative-Going Threshold Voltage				0.8	V
I _{EN+}	Logic Enable "1" Input Bias Current	V _{EN} =5 V (Pull-Down=150 KΩ)	15	33	50	μA
I _{EN-}	Logic Enable "0" Input Bias Current	V _{EN} =0 V	1		2	μA
R _{EN}	Logic Input Pull-Down Resistance		100	150	333	KΩ

Electrical Characteristics

 V_{BIAS} (V_{DD} , $V_{BS1,2,3}$) = 15.0 V and T_A = 25°C unless otherwise specified. The V_{IN} and I_{IN} parameters are referenced to V_{SS} and are applicable to all six channels. The V_O and I_O parameters are referenced to $V_{S1,2,3}$ and COM and are applicable to the respective output leads: HO1,2,3 and LO1,2,3. The V_{DDUV} parameters are referenced to V_{SS} . The V_{BSUV} parameters are referenced to $V_{S1,2,3}$.

Symbol	Parameter	Condition	Min.	Тур.	Max.	Unit
Over-Cur	rent Protection Section					
V _{CSTH+}	Over-Current Detect Positive Threshold		450	500	550	mV
V _{CSTH-}	Over-Current Detect Negative Threshold			440		mV
V _{CSHYS}	Over-Current Detect Hysteresis			60		mV
ICSIN	Short-Circuit Input Current	V _{CSIN} =1 V	5	10	15	μA
I _{SOFT}	Soft Turn-Off Sink Current		25	40	55	mA
Fault Out	put Section		1		•	
V _{RCINTH+}	RCIN Positive-Going Threshold Voltage		2.7	3.3	3.9	V
V _{RCINTH-}	RCIN Negative-Going Threshold Voltage ⁽⁵⁾			2.6		V
VRCINHYS	RCIN Hysteresis Voltage ⁽⁵⁾			0.7		V
IRCIN	RCIN Internal Current Source	C _{RCIN} =2 nF	3	5	7	μA
V _{FOL}	Fault Output Low Level Voltage	V _{CS} =1 V, I _{FO} =1.5 mA		0.2	0.5	V
RDSRCIN	RCIN On Resistance	I _{RCIN} =1.5 mA	50	75	100	Ω
R _{DSFO}	Fault Output On Resistance	I _{FO} =1.5 mA	90	130	170	Ω

Note:

5. These parameters are guaranteed by design.

Dynamic Electrical Characteristics

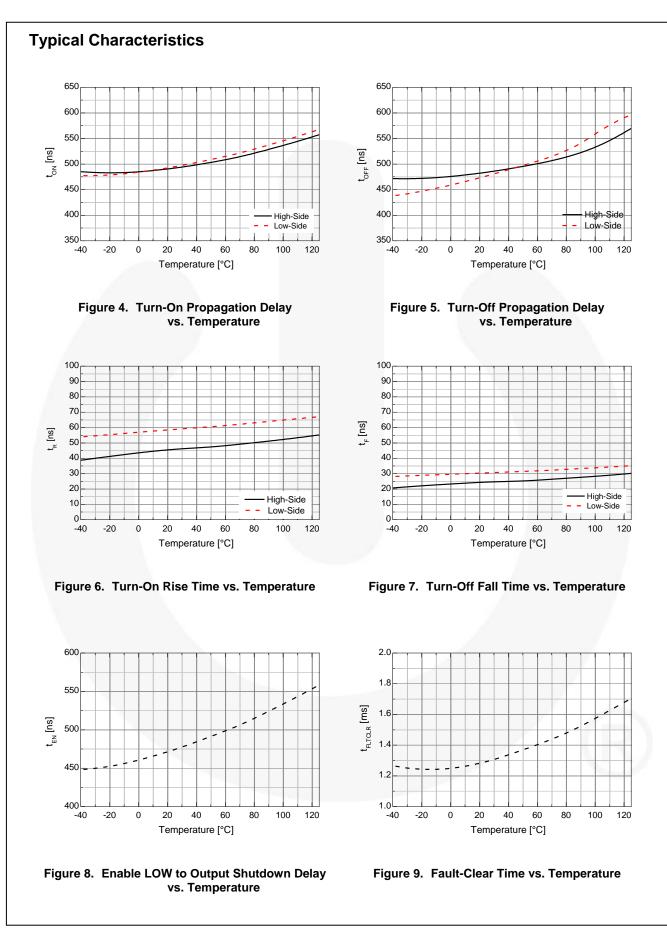
T_A=25°C, V_{BIAS} (V_{DD}, V_{BS1,2,3}) =15.0 V,V_{S1,2,3} =COM=V_{SS}, C_{RCIN}=2 nF, and C_{Load} = 1000 pF unless otherwise specified.

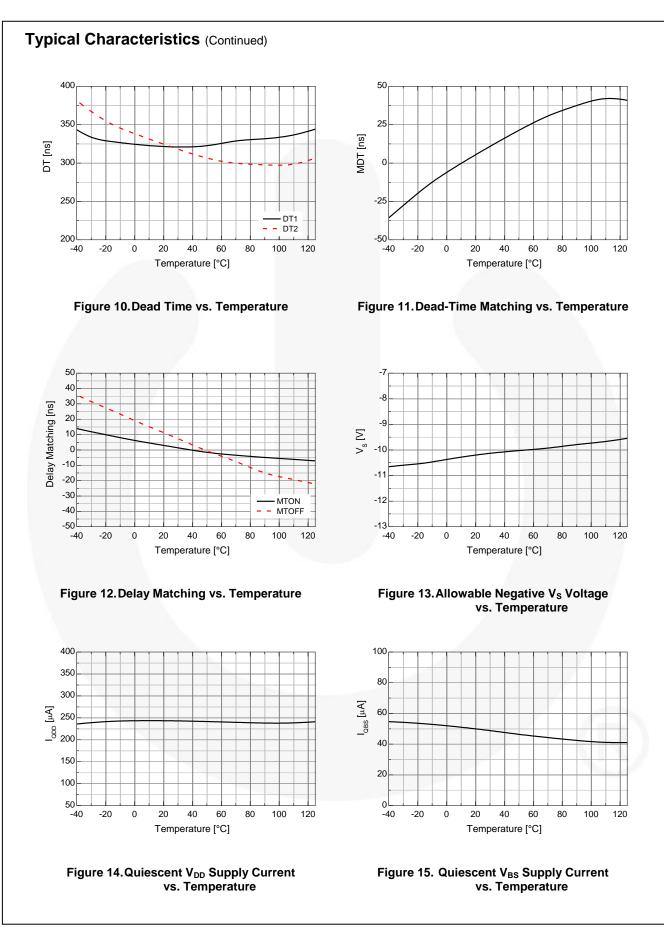
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
t _{ON}	Turn-On Propagation Delay	VLIN1,2,3=VHIN1,2,3=0 V, VS1,2,3=0 V	350	500	650	ns
t _{OFF}	Turn-Off Propagation Delay	V _{LIN1,2,3} =V _{HIN1,2,3} =5 V, V _{S1,2,3} =0 V	350	500	650	ns
t _R	Turn-On Rise Time	V _{LIN1,2,3} =V _{HIN1,2,3} =0 V	20	50	100	ns
tF	Turn-Off Fall Time	V _{LIN1,2,3} =V _{HIN1,2,3} =5 V	10	30	80	ns
t _{EN}	Enable LOW to Output Shutdown Delay		400	500	600	ns
t CSBLT	CS Pin Leading-Edge Blanking Time		400	650	850	ns
t _{CSFO}	Time from CS Triggering to FO	From V _{CSC} =1 V to FO Turn-Off		850	1300	ns
tcsoff	Time from CS Triggering to Low-Side Gate Outputs Turn-Off	From V _{CSC} =1 V to Starting Gate Turn-Off		850	1300	ns
t _{FLTIN}	Input Filtering Time ⁽⁶⁾ (HINx, LINx, EN)		170	250	330	ns
t _{FLTCLR}	Fault-Clear Time	C _{RCIN} = 2 nF		1.30	2.35	ms
DT	Dead Time		230	320	400	ns
MDT	Dead-Time Matching (All Six Channels)				50	ns
MT	Delay Matching (All Six Channels)				50	ns
PM	Output Pulse-Width Matching ⁽⁷⁾	PW _{IN} > 1 μs		50	100	ns

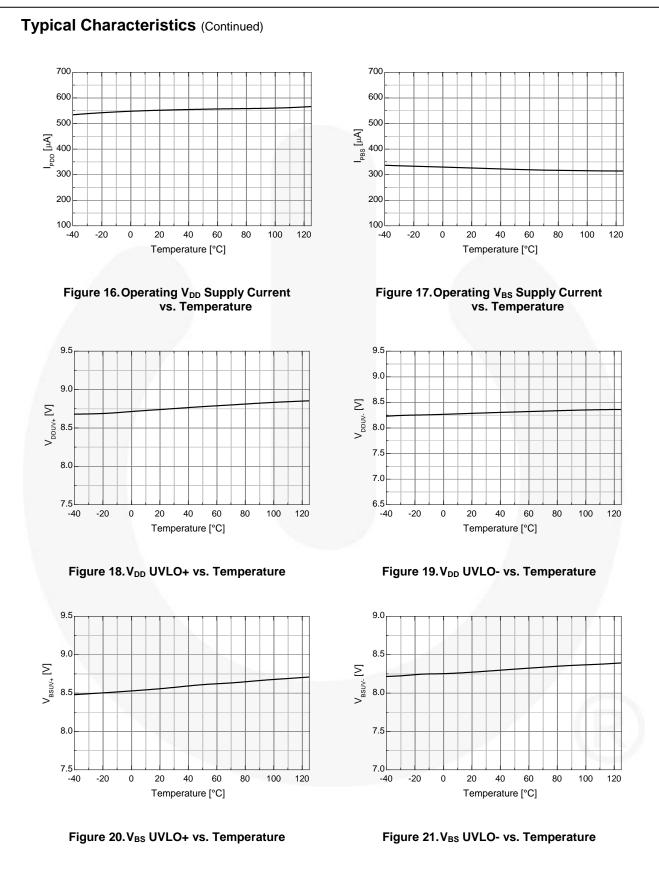
Notes:

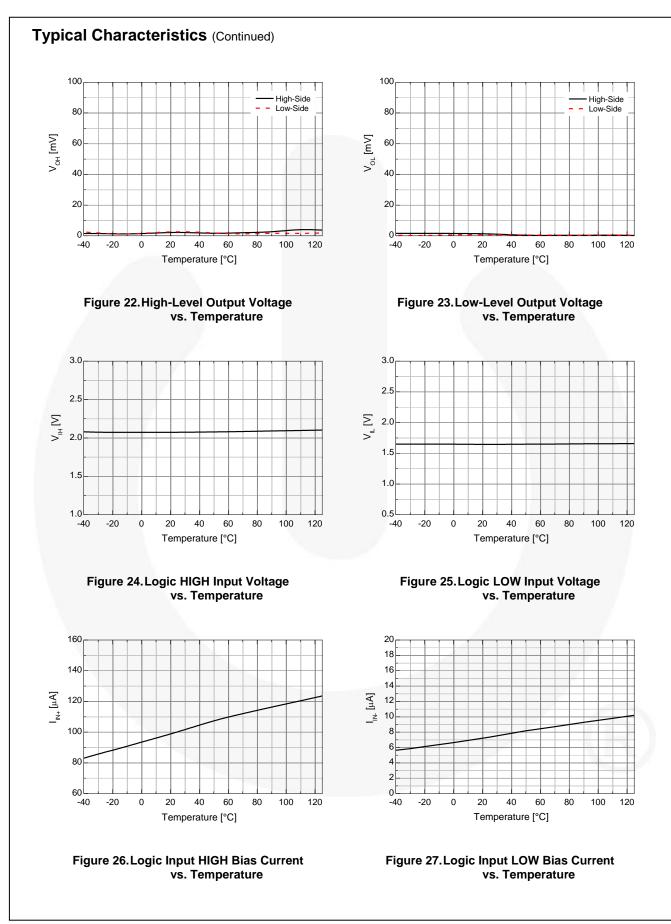
6. The minimum width of the input pulse should exceed 500 ns to ensure the filtering time of the input filter is exceeded.

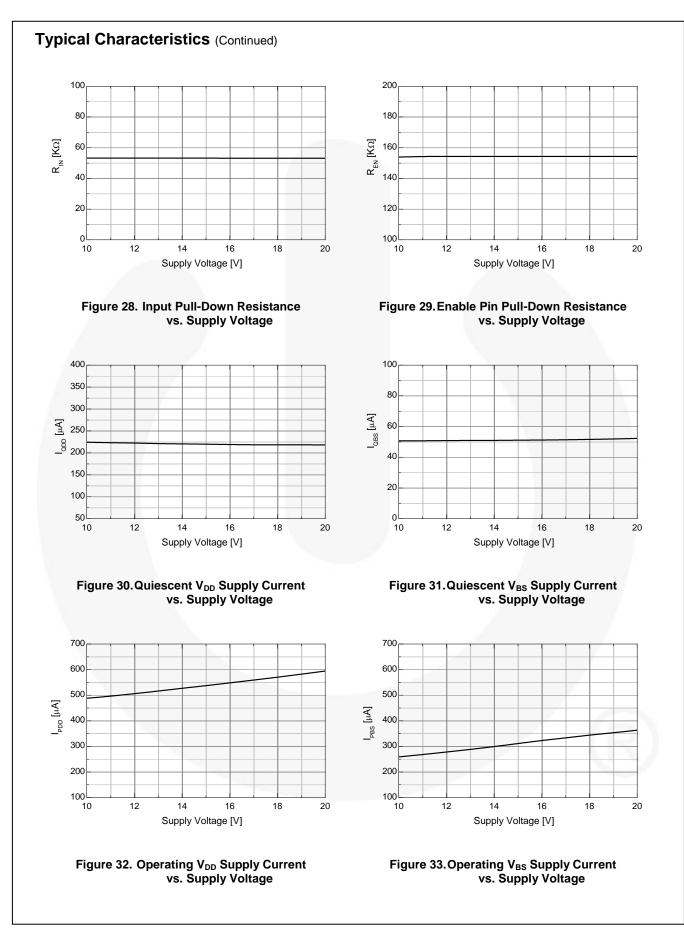
7. PM is defined as PW_{IN}-PW_{OUT}.

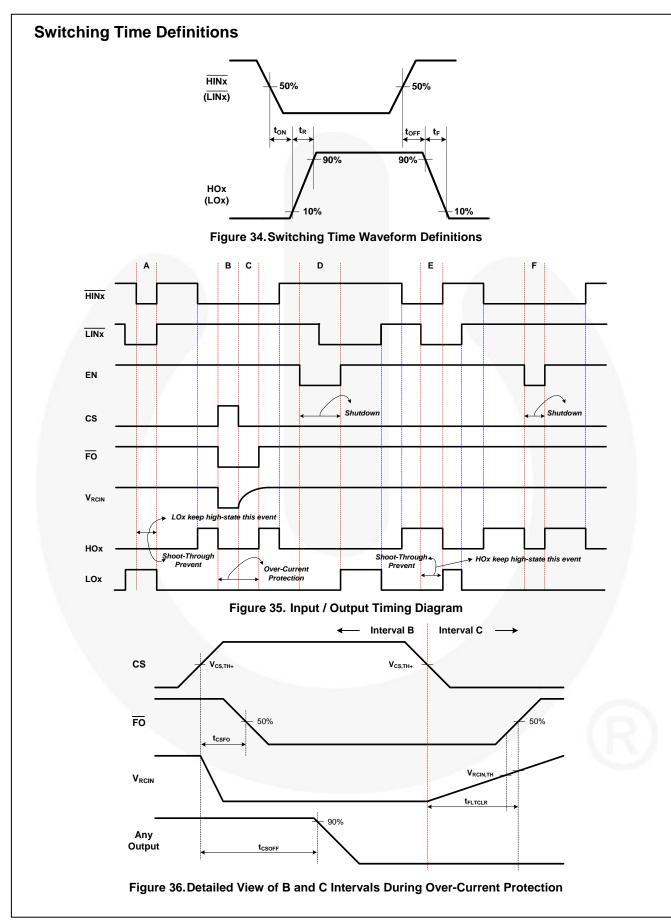












Applications Information

1. Dead Time

Dead time is automatically inserted whenever the dead time of the external two input signals (between HINx and LINx signals) is shorter than internal fixed dead times (DT1 and DT2). Otherwise, external dead times larger than internal dead times are not modified by the gate driver and internal dead-time waveform definition is shown in Figure 37.

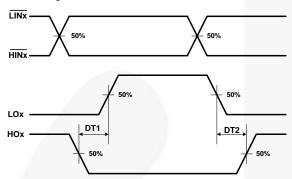


Figure 37. Internal Dead-Time Definitions

2. Protection Function

2.1 Fault Out (FO) and Under-Voltage Lockout

The high- and low-side drivers include Under-Voltage Lockout (UVLO) protection circuitry that monitors the supply voltage for V_{DD} and V_{BS} independently. It can be designed to prevent malfunction when V_{DD} and V_{BS} are lower than the specified threshold voltage. The UVLO hysteresis prevents chattering during power-supply transitions. Moreover, the fault signal (power supply voltage FO) goes to LOW state to operate reliably during power-on events when the power supply (V_{DD}) is below the under-voltage lockout high threshold voltage for the circuit (during $t_1 \sim t_2$). The UVLO circuit is not otherwise activated; shown Figure 38. If V_{DD} is lower than 3.5 V, the fault signal cannot be driven to LOW state because V_{DD} is not enough to drive internal circuit.

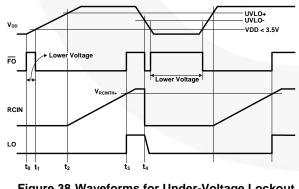
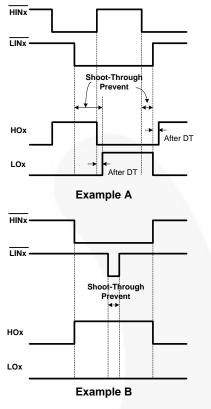
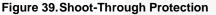


Figure 38. Waveforms for Under-Voltage Lockout

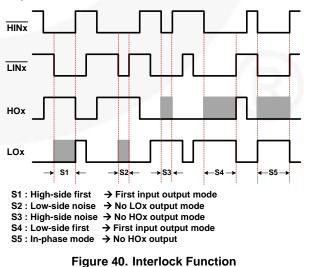
2.2 Shoot-Through Protection

The shoot-through protection circuitry prevents both high- and low-side switches from conducting at the same time, as shown Figure 39.





An interlock function is a device used to prevent both high- and low-side switches from conducting at the same time as shown Figure 40. In most applications an interlock is used to help prevent a device from harming its operator or damaging itself by when two input signals of a same leg are activated simultaneously, only one output is activated.



2.3 Enable Input

When the EN pin is in HIGH state, the gate driver operates normally. When a condition occurs that should shut down the gate driver, the EN pin should be LOW. The enable circuitry has an input filter; the minimum input duration is specified by t_{FLTIN} (typically 250 ns).

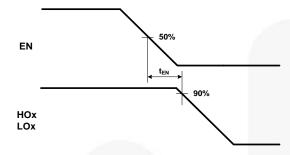


Figure 41. Output Enable Timing Waveform

2.4 Fault-Out (FO) and Over-Current Protection

FAN73893 provides an integrated fault output (\overline{FO}) and an adjustable fault-clear timer (t_{FLTCLR}). There are two situations that cause the gate driver to report a fault via the \overline{FO} pin. The first is an under-voltage condition of low-side gate driver supply voltage (V_{DD}) and the second is when the current-sense pin (CS) recognizes a fault. If a fault condition occurs, the \overline{FO} pin is internally pulled to COM, the fault-clear timer is activated, and all outputs (HO1, 2, 3 and LO1, 2, 3) of the gate driver are turned off. The fault output stays LOW until the fault condition has been removed and the fault-clear timer expires. Once the fault-clear timer expires, the voltage on the \overline{FO} pin returns to pull-up voltage.

The fault-clear time (t_{FLTCLR}) is determined by an internal current source (I_{RCIN} =5 μ A) and an external C_{RCIN} at the RCIN pin, as shown as:

$$t_{FLTCLR} = \frac{C_{RCIN} \times V_{RCIN,TH}}{I_{RCIN}} [s]$$
(1)

The R_{DSRCIN} of the MOSFET is a characteristic discharge curve with respect to the external capacitor C_{RCIN}. The time constant is defined by the external capacitor C_{RCIN} and the R_{DSRCIN} of the MOSFET.

The output of current-sense comparator (CS_COMP) passes a noise filter, which inhibits an over-current shutdown caused by parasitic voltage spikes of V_{CS} .

This corresponds to a voltage level at the comparator of V_{CSTH+} - V_{CSHYS}= 500 mV - 60 mV =440 mV, where V_{CSHYS}=60 mV is the hysteresis of the current comparator (CS_COMP), as shown in Figure 42.

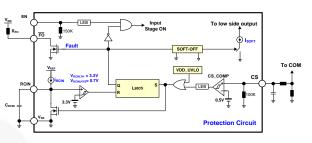


Figure 42. Over-Current Protection

Figure 43 shows the waveform definitions of RCIN, FO, and the low-side driver; which uses a soft turn-off method when an under-voltage condition of the low-side gate driver supply voltage (V_{DD}) or the current-sense pin (<u>CS</u>) recognizes a fault. If a fault condition occurs, the FO Pin is internally pulled to COM and all outputs (HO1,2,3 and LO1,2,3) of the gate driver are turned off. Low-side outputs decline linearly by the internal sink current source (I_{SOFT}=40 mA) for soft turn-off, as shown in Figure 43.

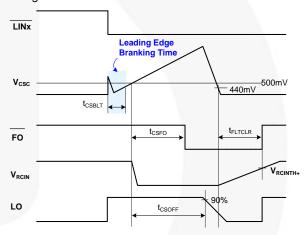


Figure 43. R_{CIN} and Fault-Clear Waveform Definition

3. Noise Filter

3.1 Input Noise Filter

Figure 44 shows the input noise filter method, which has symmetry duration between the input signal (t_{INPUT}) and the output signal (t_{OUTPUT}) and helps to reject noise spikes and short pulses. This input filter is applied to the HINx, LINx, and EN inputs. The upper pair of waveforms (Example A) shows an input signal duration (t_{INPUT}) much longer than input filter time (t_{FLTIN}); it is approximately the same duration between the input signal time (t_{INPUT}) and the output signal time (t_{OUTPUT}). The lower pair of waveforms (Example B) shows an input signal time (t_{INPUT}) slightly longer than input filter time (t_{FLTIN}); it is approximately the same duration between input signal time (t_{INPUT}) and the output signal time (t_{OUTPUT}).

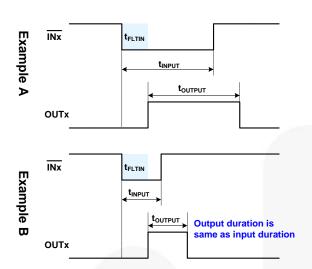


Figure 44.Input Noise Filter Definition

3.2. Short-Pulsed Input Noise Rejection Method

The input filter circuitry provides protection against short-pulsed input signals (HINx, LINx, and EN) on the input signal lines by applied noise signal.

If the input signal duration is less than input filter time (t_{FLTIN}) , the output does not change states.

Example A and B of the Figure 45 show the input and output waveforms with short-pulsed noise spikes with a duration less than input filter time; the output does not change states.

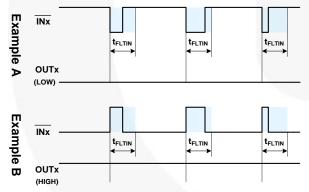


Figure 45. Noise Rejecting Input Filter Definition

Figure 46 shows the characteristics of the input filters while receiving narrow ON and OFF pulses. If input signal pulse duration, PW_{IN} , is less than input filter time, t_{FLTIN} ; the output pulse, PW_{OUT} , is zero. The input signal is rejected by input filter. Once the input signal pulse duration, PW_{IN} , exceeds input filter time, t_{FLTIN} , the output pulse durations, PW_{OUT} , matches the input pulse durations, PW_{IN} . FAN73893 input filter time, t_{FLTIN} , is about 250 ns for the high- and low-side outputs.

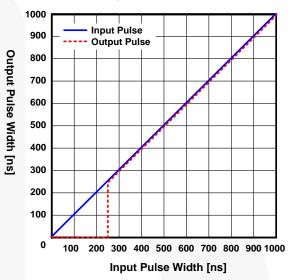
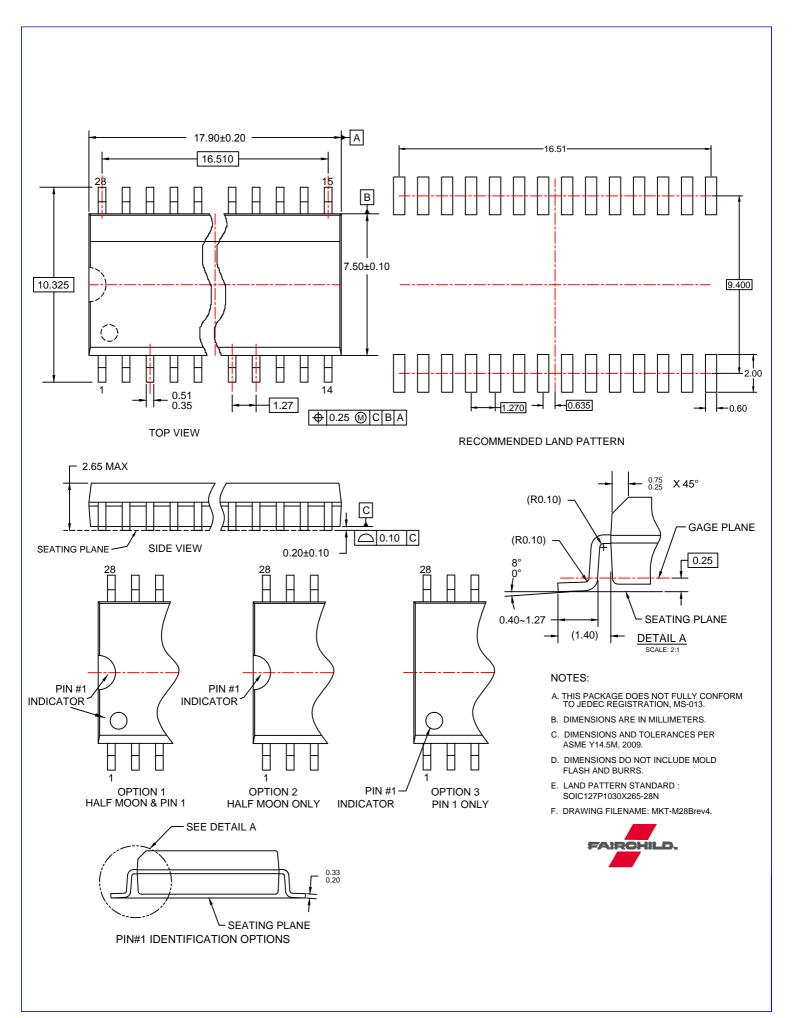


Figure 46.Input Filter Characteristic of Narrow ON



ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor haves against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death a

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

© Semiconductor Components Industries, LLC